## Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination LEE, JAE-GOO Examiner Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,555,481 B2	04-2003	Nakamura, Shunji	438/734
	В	US-6,291,847 B1	09-2001	Ohyu et al.	257/306
	С	US-6,400,628 B2	06-2002	Dosaka et al.	365/210
	D	US-5,972,747	10-1999	Hong, Ki-Gak	438/253
	E	US-5,629,539	05-1997	Aoki et al.	257/306
	F	US-5,604,365	02-1997	Kajigaya et al.	257/296
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					-
	Q					
	R					
	S				:	
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.